Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination	
10098586	KRAJEWSKI ET AL.	
Examiner	Art Unit	
SARA CHANDLER	3693	

	SEARCHED				
Class		Subclass	Date	Examiner	
705	20		06/17/09	CMC	

SEARCH NOTES				
Search Notes	Date	Examiner		
East (keyword, class/subclass, foreign)	06/17/08	SMC		
STIC (NPL, foreign)	06/17/08	SMC		
Dialog (NPL)	06/10/08	SMC		
Allowance Conference w/ Jay Kramer and Jagdish Patel				

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
705	38	06/17/08	SMC			

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